

# Experimental Techniques of Optics

**Spring 2015**

PHYC 476,477, 302L

University of New Mexico

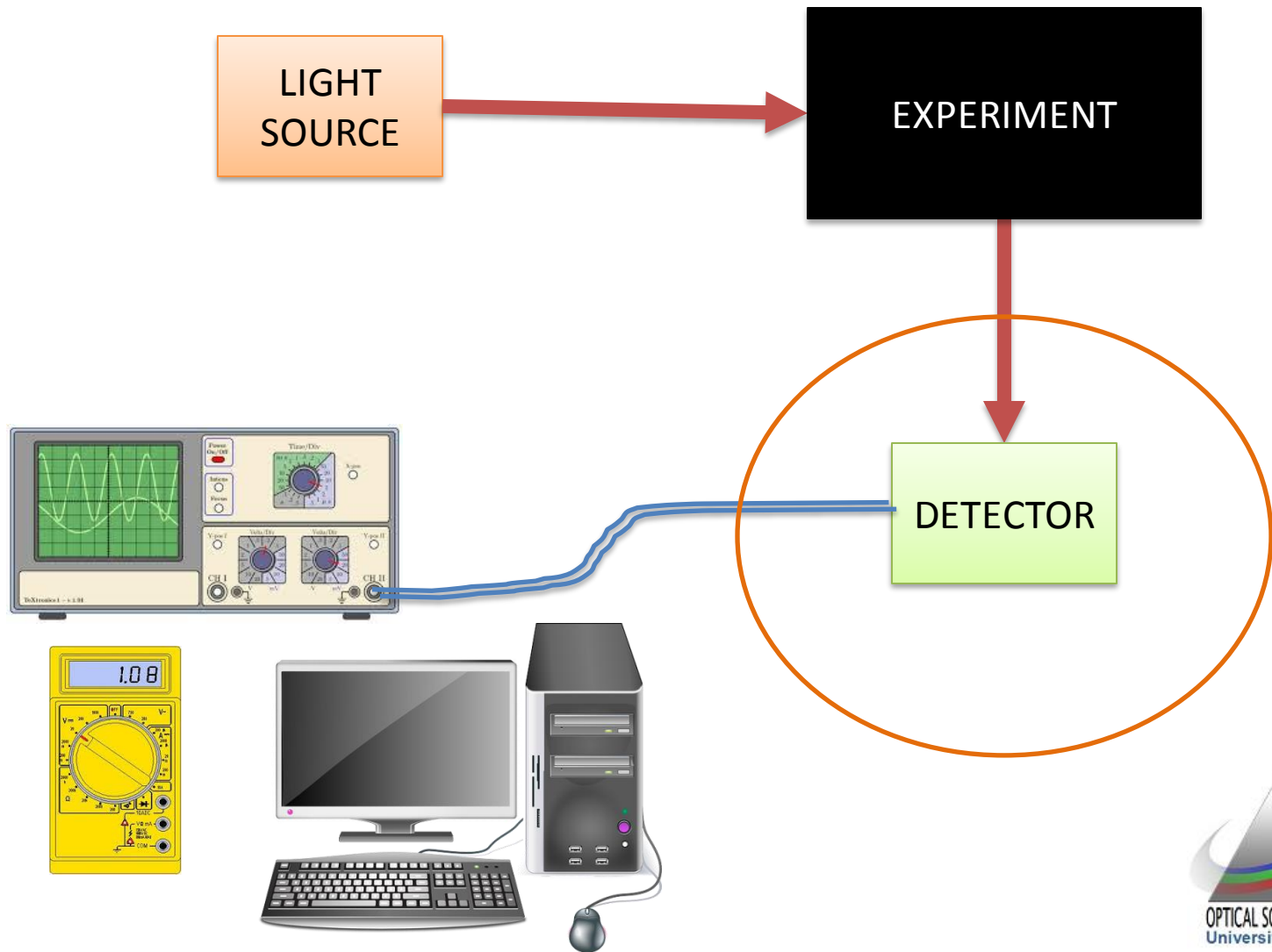
<http://www.optics.unm.edu/sbahae/OpticsLab/>

## OPTICAL SENSORS TUTORIAL

**Mansoor Sheik-Bahae**

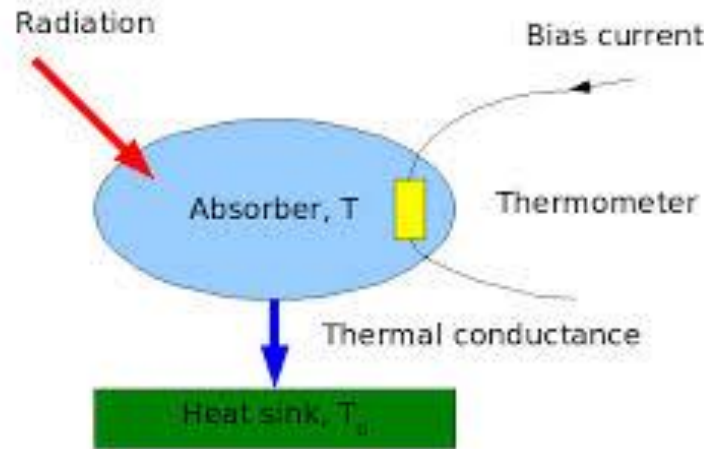


# IN ANY OPTICS EXPERIMENT

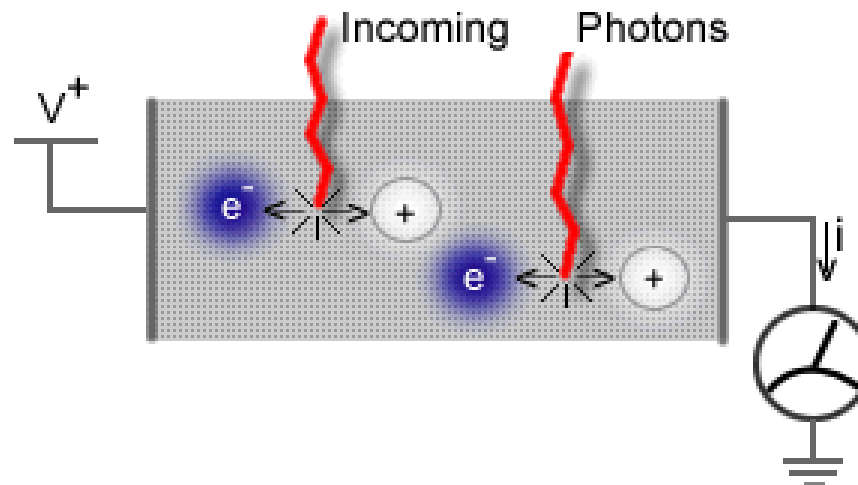


# Detector Types (mostly)

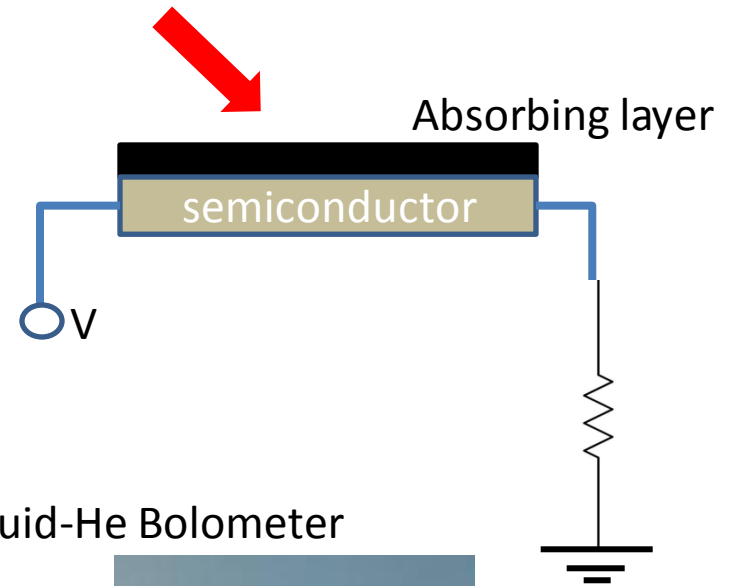
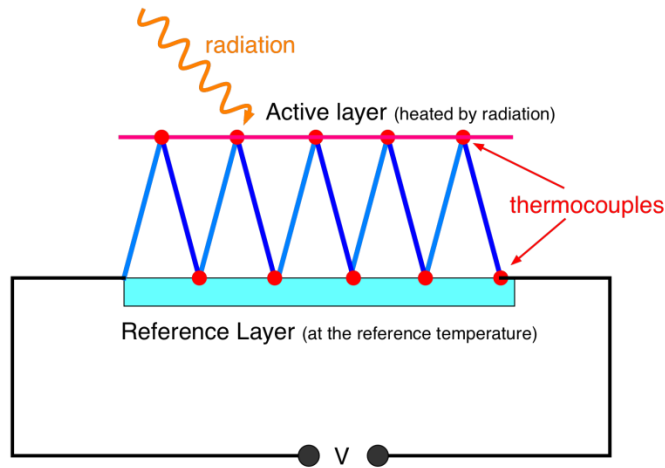
- Thermal



- Quantum



# Thermal (Bolometric) Optical Detectors



Liquid-He Bolometer



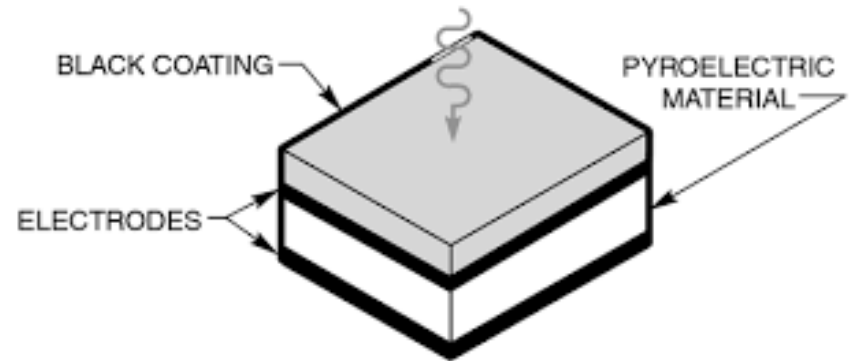
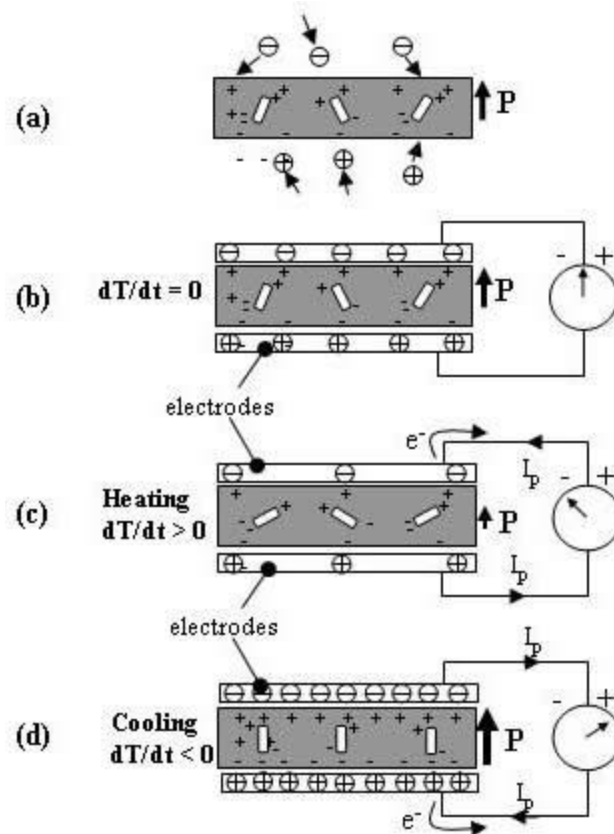
Example: Power Meters



Response time: SLOW! 10-100 Hz

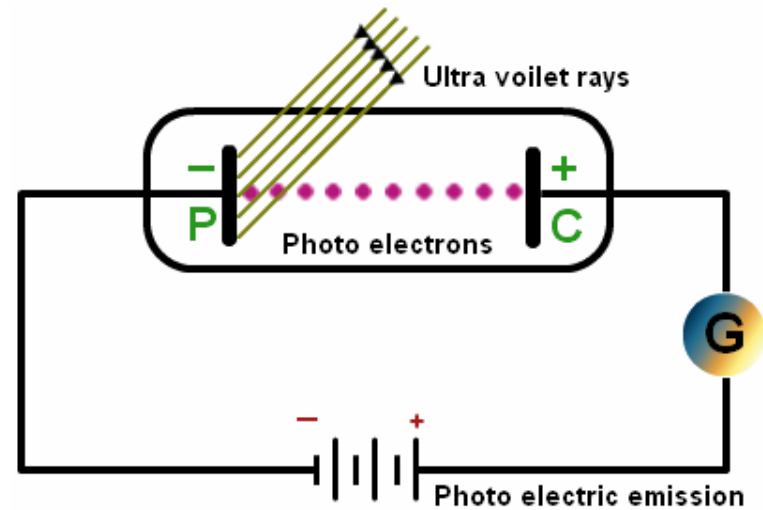
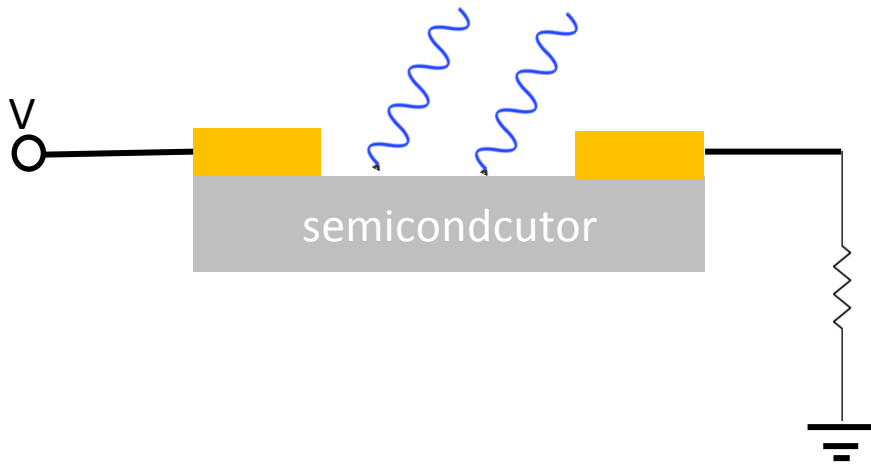
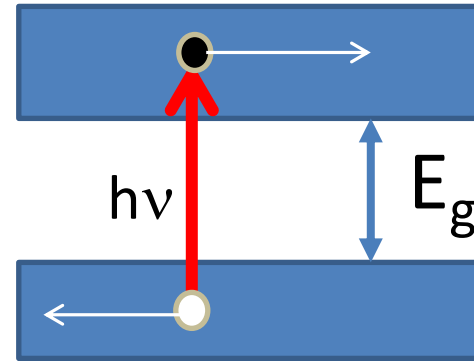
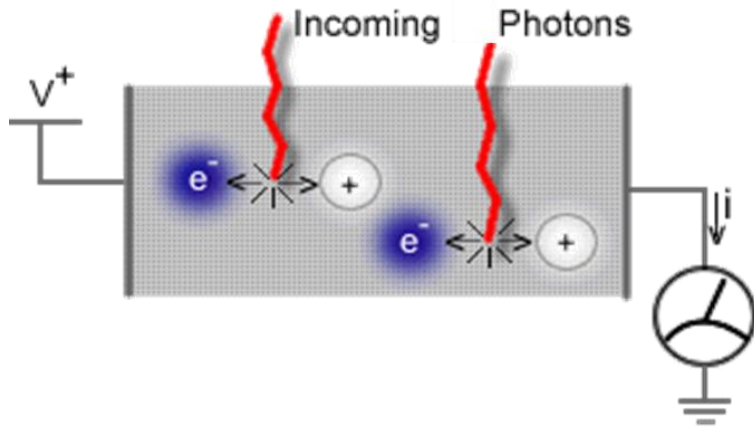
# Thermal (Bolometric) Optical Detectors

## Pyroelectric Effect



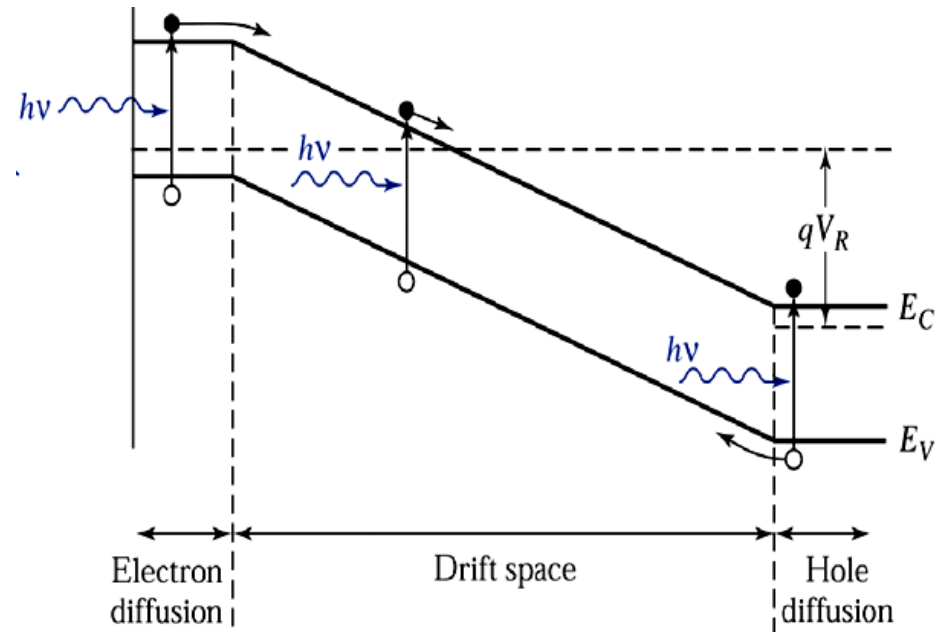
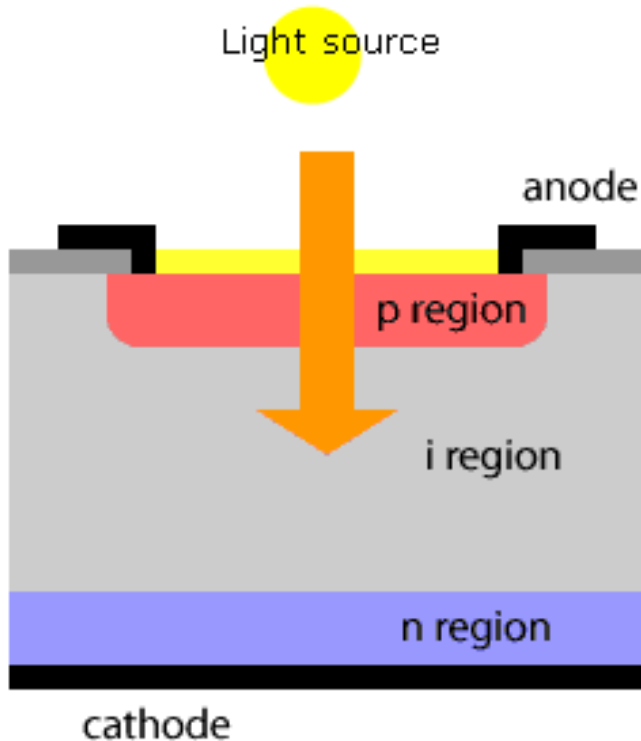
Only measures AC (pulses, etc.), Can have fast rise time

# Quantum (Photon) Detector

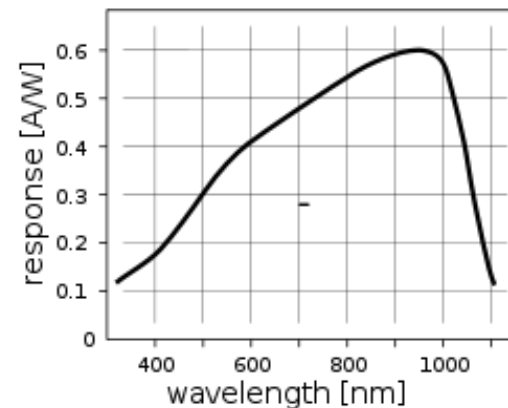


# Quantum (Photon) Detector

## The photodiode

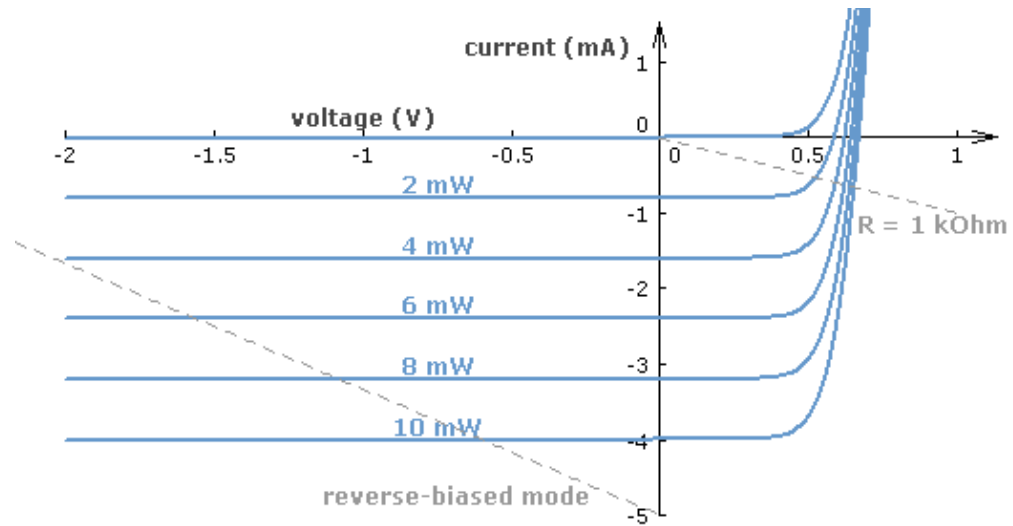
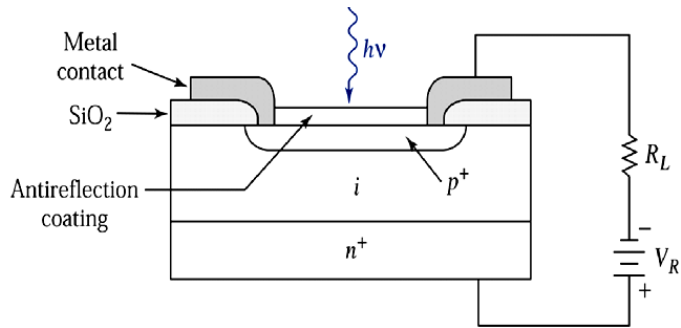


$$\mathfrak{R} = \frac{I_P}{P_0} = \frac{\eta q}{h \nu} \quad [\text{A/W}]$$

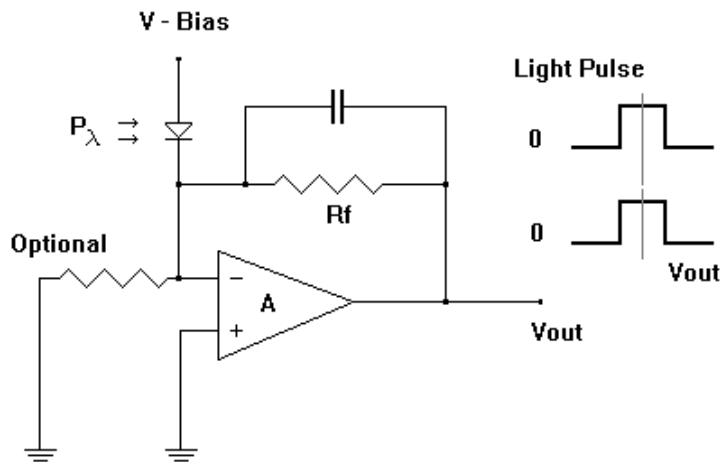


# Quantum (Photon) Detector

## The photodiode

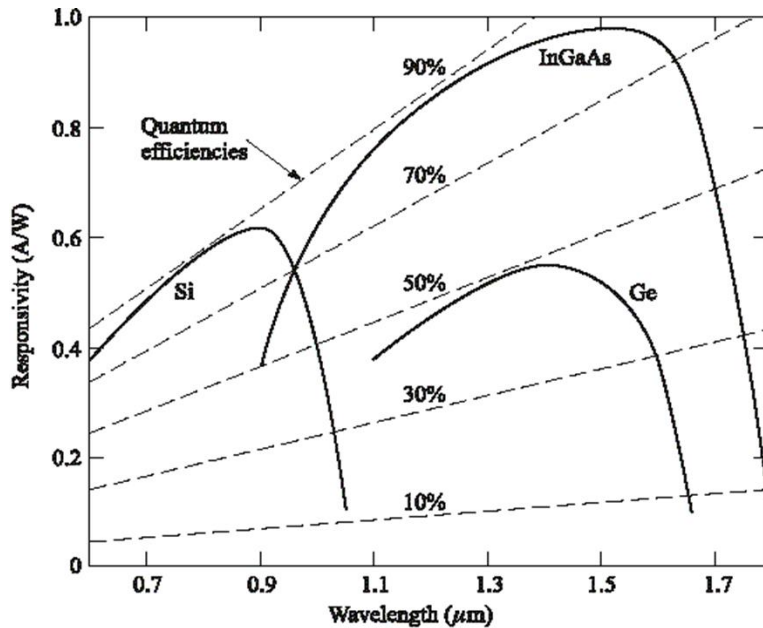


Negative Bias Circuit





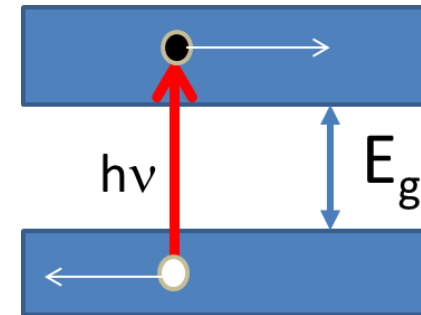
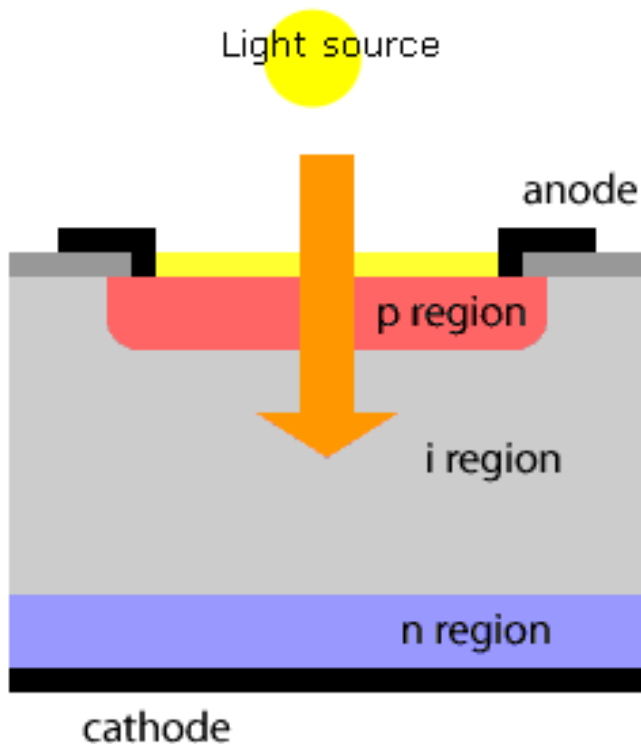
# Photodiodes



$$\mathfrak{R} = \frac{I_P}{P_0} = \frac{\eta q}{h \nu} \quad [\text{A/W}]$$

# Quantum (Photon) Detector

## The Response Time



Ultimately depends on two responses :

1- transit time  $t_d = \frac{w}{v_d}$  Width of depletion region  
Drift velocity

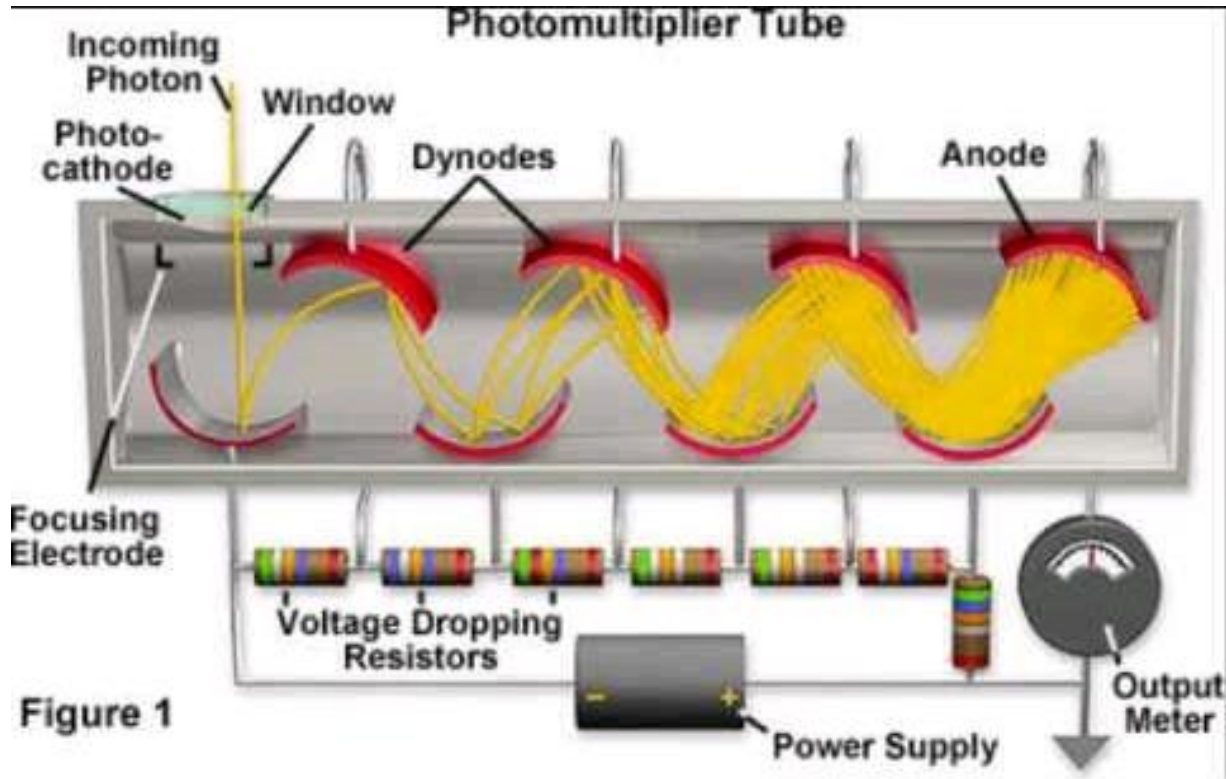
and

2- RC time

$$t_{RC} = R \times C_{total}$$

Fast detectors have smaller area!

# Photomultiplier Tubes (PMT)

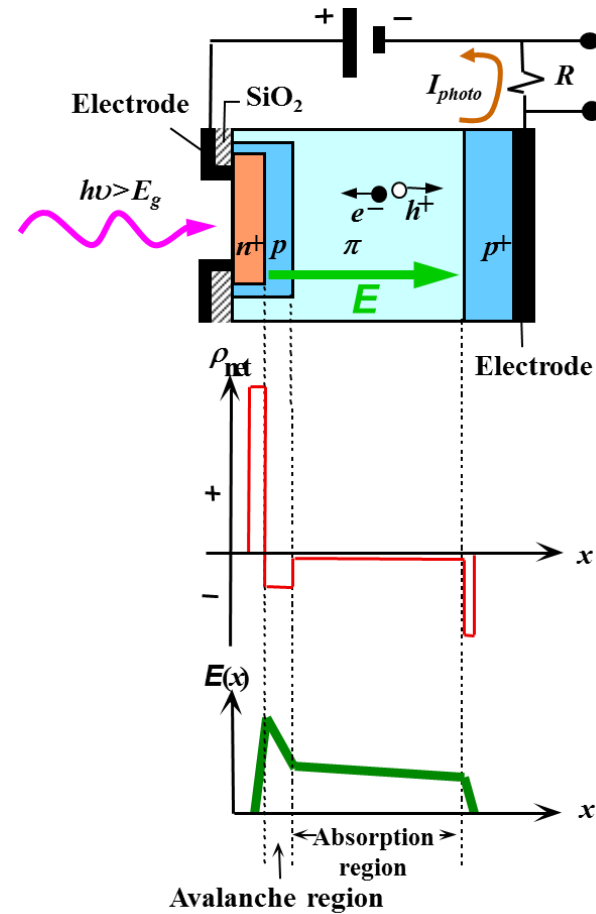
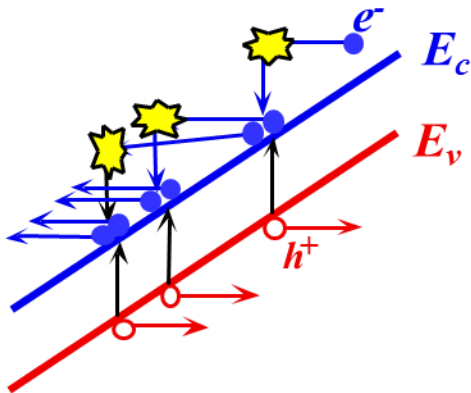
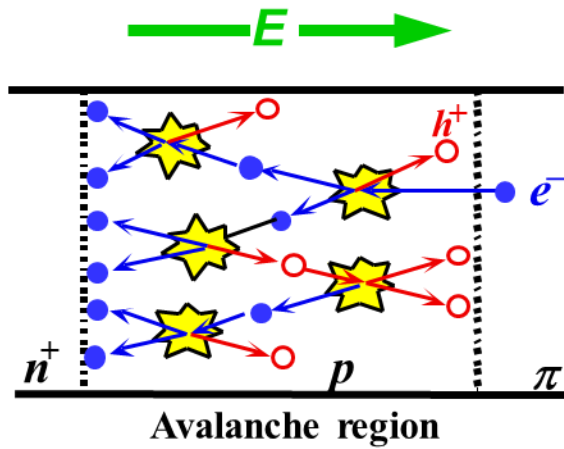


- High gain ( $10^7$ )
- Low noise
- Fast (ns)
- Single-photon sensitivity
- Large area

High voltage (kV)



# Avalanche Photodiodes (APD)



# APD

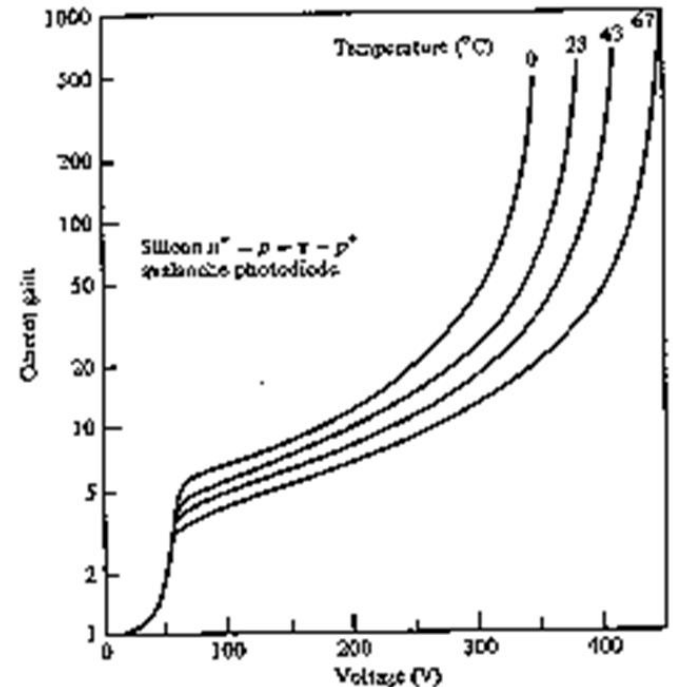
Gain  $< 10^6$  (100-1000 typical)



$$\mathfrak{R}_{\text{APD}} = \frac{\eta q}{h\nu} M = \mathfrak{R}_0 M$$

Small area

Photodiode	$\lambda_{\text{range}}$ nm	$\lambda_{\text{peak}}$ nm	R at peak A/W	Gain	Rise time ns	$I_{\text{dark}}$
Si APD	400-1100	830-900	40-130	10-100	0.1	1-10nA
Ge APD	700-1700	1500-1600	4-14	10-20	0.1	1-10 $\mu$ A
InGaAS APD	800-1700	1500-1600	7-18	10-20	0.07-0.1	10-100nA

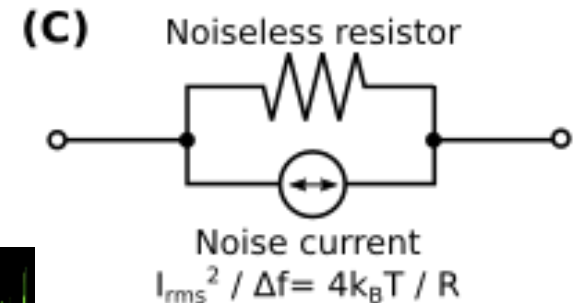
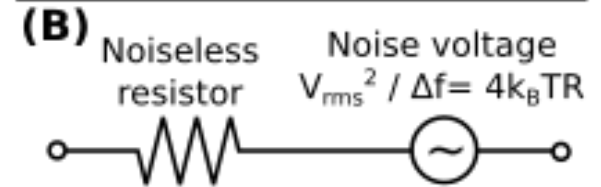
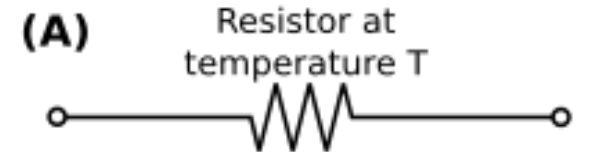
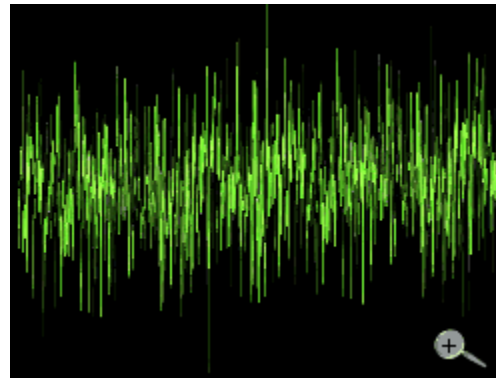


# Thermal (Johnson) Noise (dark current)

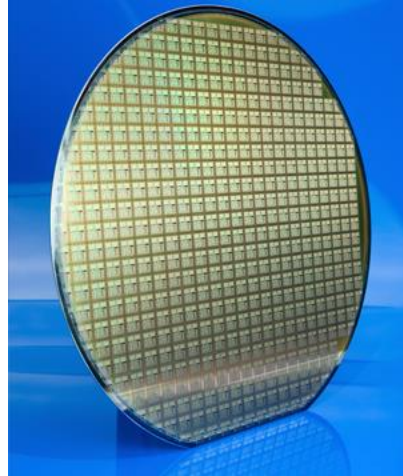
$$\langle i_T^2 \rangle = \sigma_T^2 = \frac{4k_B T B}{R_L}$$

$$v_n = \sqrt{k_B T / C}$$

Noise of capacitors at 300 K		
Capacitance	Voltage	Electrons
1 fF	2 mV	12.5 e <sup>-</sup>
10 fF	640 μV	40 e <sup>-</sup>
100 fF	200 μV	125 e <sup>-</sup>
1 pF	64 μV	400 e <sup>-</sup>
10 pF	20 μV	1250 e <sup>-</sup>
100 pF	6.4 μV	4000 e <sup>-</sup>
1 nF	2 μV	12500 e <sup>-</sup>

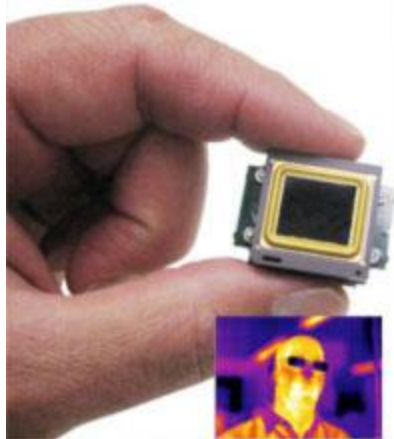
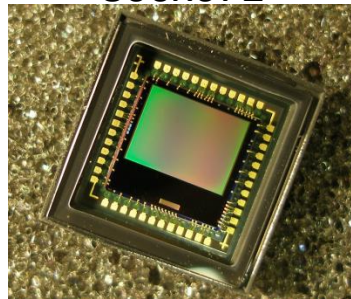


# Finally, few words on cameras



- 2D sensor arrays
- individually addressable (CMOS cameras)
- Thermal or quantum pixels

800x672



Si micro-bolometer array

